

<b>Notice of References Cited</b>	Application/Control No. 09/864,107	Applicant(s)/Patent Under Reexamination VAN LIERE, FILIPS	
	Examiner JIN-CHENG WANG	Art Unit 2628	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,832,422	11-1998	Wiedenhoefer, Curt	702/154
*	B	US-5,410,494	04-1995	Hashimoto et al.	345/173
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

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